

The Importance of the Electron Mean Free Path for Superconducting Radio-Frequency Cavities

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"The importance of the electron mean free path for superconducting radio-frequency cavities"

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Impurity-Doping Observations

• Classic observation: minimum in R_{BCS} vs. mean free path







Impurity-Doping Observations

• Recent observation: anti-Q-slope from impurity doping









- Low-field minimum comes from BCS theory
- Recent theory offers explanation for **anti-Q-slope**
 - A. Gurevich (ODU): current-induced smearing of energy gap causes field-dependent reduction in surface resistance









- Strong RF magnetic fields excite screening currents on superconducting surface which modify density of states of quasiparticles (unpaired electrons)
- Decreases R_s for sufficiently sharp gap peak





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- **Doping** connection: doping Nb sharpens gap peak?
 - Early results indicated more uniform energy gap on surface, but need more systematic data







• Quasiparticle overheating

$$T - T_0 = \alpha' \frac{1}{2} H_a^2 R_{BCS}(H_a, T) = \alpha' \frac{P_{diss}}{area}$$







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 Magnitude of R_{BCS} reduction controlled by quasiparticle overheating



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- 1.3 GHz Nitrogen-doped TESLA single-cell niobium cavities
- Prepared with varied doping recipes to achieve a range of electron mean free paths from 4 nm to over 200 nm
- CW RF tests at Cornell









RF Test Results and Analysis

• Extract mean free path, R_{BCS}(H, T)









- Fit Gurevich theory to experimental data
 - $-\alpha$ ' as free fitting parameter



mfp = 4.5 nm

mfp = 34 nm

mfp = 213 nm







stronger doping ↓ lower mean free path ↓ lower overheating ↓ stronger anti-Q-slope

This is what connects **impurity doping** to observed strength of **anti-Q-slope**







- Optimizing the mean free path
 - Account for sensitivity of R_0 to trapped flux







- New tests: Low-temperature impurity-doped 1.3 GHz TESLA niobium cavities
- Simpler doping procedure no post-doping chemical etching
- Different impurities high levels of C, O
- CW RF tests at Cornell









• Similar RF performance to N-doped cavities





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Low-Temperature Doping

- Fit using same procedure as before
 - Single α ' for all temperatures









• Good agreement with **N-doping** model



- Drastic differences in RF penetration layer
 - How does this change the physics?

- Theoretical link between doping level, mean free path, quasiparticle overheating and the anti-Q-slope
- Promising/interesting early results with low-T doping

Thank you for your attention!

- References / further reading:
 - J. T. Maniscalco, D. Gonnella, and M. Liepe, J. Appl. Phys. **121**, 043910 (2017).
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 - P. N. Koufalis, D. L. Hall, M. Liepe, and J. T. Maniscalco, arXiv:1612.08291 (2016).
 - J. T. Maniscalco, F. Furuta, D. L. Hall, P. N. Koufalis, M. Liepe, IPAC 2017 (WEPVA145).
 - This conference: **TUPB009**, **THPB004**, **THPB005**, **THPB006**

$$R_{\rm s} = R_0 + R_{\rm BCS}$$

- $T = T_{electron} =$ temperature of guasiparticles T_0 = cryogenic bath temperature
 - α' = normalized overheating parameter Y = electron-phonon energy transfer rate κ = thermal conductivity d = thickness of cavity wall h_{K} = Kapitza interface conductance

- Nitrogen-doped 1.3 GHz TESLA single-cell niobium cavities
 - Prepared with a range of electron mean free paths from 4 nm to over 200 nm
 - 100 µm vertical electropolish (VEP) "reset"
 - 800 °C in vacuum, 3 h, "outgassing"
 - 800-990 °C in 4-8 Pa (30-60 mTorr) N₂, 5-30 min
 - 5-40 µm VEP to determine "doping level", quantified by electron mean free path (deeper etch reveals cleaner layer)
- Low-T doping at 120-160° C
 - chemical reset and outgassing bake phase
 - 48 h bake with nitrogen gas, impurities at ppm level
 - 48-168 h anneal in vacuum

